# STF Test Development 

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## STF Uses



- Production testing of basic DOM functionality
- Hardware, firmware, and software verification
- Laboratory investigations
"If it's not tested, it's broken..."


## STF Structure

Efficient, parameterized, but limited data output

Inefficient, but flexible output stream


FPGA, CPLD memory-mapped registers

## HV Stability

- Set high voltage base DAC, monitor ADC readout over time (currently $\sim 5 \mathrm{~min}$ )
- Pass conditions (preliminary)
- RMS < 1V
- Error of mean < 5V
- Error of max/min < 5V




## HV Ramp

- Ramp high voltage up and down full range, monitor ADC
- Pass conditions (preliminary)
- Max error < 5V



## Other Tests

- ATWD, FADC suite developed at LBNL
- PMT P/V ratio (in progress)
- Coordinating with A. Goldschmidt on further development


## Self-heating Test

DOM Heating (Board Sensor)


- Order-ofmagnitude selfheating test for Bartol
- STF used for continuous temperature readout
- Around $9^{\circ} \mathrm{C}$ differential


## Pressure Test

- Needed live pressure readout for IceTop DOM sealing
- Separately verified readout with vacuum chamber gauge
- Used STF to monitor pressure during sealing


